

Search Notes

Application/Control No.

10/659,172

Examiner

Michael C. Wimer

Applicant(s)/Patent under
Reexamination

HEIN ET AL.

Art Unit

2828

SEARCHED

Class	Subclass	Date	Examiner
343	705,754, 755	11/23/2005	MCW
455	13.1,13.2	11/23/2005	MCW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR